S arch Notes

Application/Control No.	Applicant(s)/Patent under Re xamination	
10/500,067	LEE ET AL.	
Examiner	Art Unit	
 Christopher RoDee	1756	

	SEAR	CHED	
Class	Subclass	Date	Examiner
430	106.1 106.3 108.6 108.7	6/20/2006	CDR

INT	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
	<u> </u>		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East search as enclosed	6/20/2006	CDR		